

	Type	L #	Hits	Search Text	DBs	Time Stamp
1	BRS	L1	1519	(C-doped or carbon-doped or ((C or carbon) near5 dop\$4)) near10 (oxide or dioxide or SiO2 or SiO?sub\$2)	USPAT; US-PG PUB; EPO; JPO; DERW ENT; IBM_TD B	2002/12/23 10:53
2	BRS	L8	387	1 same (interlayer or ILD or intermetal or dielectric or insulat\$4)	USPAT; US-PG PUB; EPO; JPO; DERW ENT; IBM_TD B	2002/12/23 10:54

File 1:ERIC 1966-2002/1981  
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File 2:INSPEC 1969-2002/Dec W3  
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File 3:INSPEC 1969-1982  
(c) 1993 Institution of Electrical Engineers  
File 4:INSPEC 1983-2002/Dec W3  
(c) 2002 Institution of Electrical Engineers

Set	Items	Description
S1	42	(C-DOP? OR CARBON-DOP?) AND (OXIDE OR DIOXIDE OR SIO?)
S2	21	RD (unique items)
S3	13	S2 AND (LOW-K OR LOW)